

## Special Issue

# Structural Monitoring Using Advanced NDT Techniques

### Message from the Guest Editors

Advanced NDT (nondestructive testing) techniques are excellent tools in order to safely maintain structures such as bridges, tunnels, and buildings, as well as cars, airplanes, ships, etc. Over the course of several decades, NDT techniques were developed to be more precise. This Special Issue of Applied Science, "Structural Monitoring Using Advanced NDT techniques", will provide recent achievements in structural monitoring and materials characterization using advanced NDT techniques. In addition, this Issue will include some papers presented in WCNDT (World Conference on Non-Destructive-testing) 2020. Your contribution is welcome and much appreciated as an author or a reviewer.

Prof. Dr. Yi-qing Ni

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#### Guest Editors

Prof. Dr. Il-Bum Kwon

Prof. Dr. Yi-Qing Ni

Dr. Donghoon Kang

Prof. Dr. Dae-Hyun Kim

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#### Deadline for manuscript submissions

closed (30 June 2022)



## Applied Sciences

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## About the Journal

### Message from the Editor-in-Chief

As the world of science becomes ever more specialized, researchers may lose themselves in the deep forest of the ever increasing number of subfields being created. This open access journal Applied Sciences has been started to link these subfields, so researchers can cut through the forest and see the surrounding, or quite distant fields and subfields to help develop his/her own research even further with the aid of this multi-dimensional network.

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### Editor-in-Chief

Prof. Dr. Giulio Nicola Cerullo  
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